


<b>Search Notes</b>  	<b>Application/Control No.</b>  10759895	<b>Applicant(s)/Patent Under Reexamination</b>  EDEN ET AL.
	<b>Examiner</b>  San Juan, Martin Jeriko P	<b>Art Unit</b>  2109

SEARCHED			
Class	Subclass	Date	Examiner
713	154	7/6/2007	MJSJ
713	154	7/6/2007	MJSJ

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (see attached)	2/2/2007	MJSJ
Inventor Search, reviewed related applications (see attached)	2/15/2007	MJSJ
Consulted with Art Unit 2132 (Lanier, Benjamin)	2/20/2007	MJSJ
Consulted with Art Unit 2132 (Nobahar, Hakim) -- Response to Arguments	6/27/2007	MJSJ
EAST Search 2nd (see attached)	6/25/2007	MJSJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner